

Progress of x-ray tests at ETH

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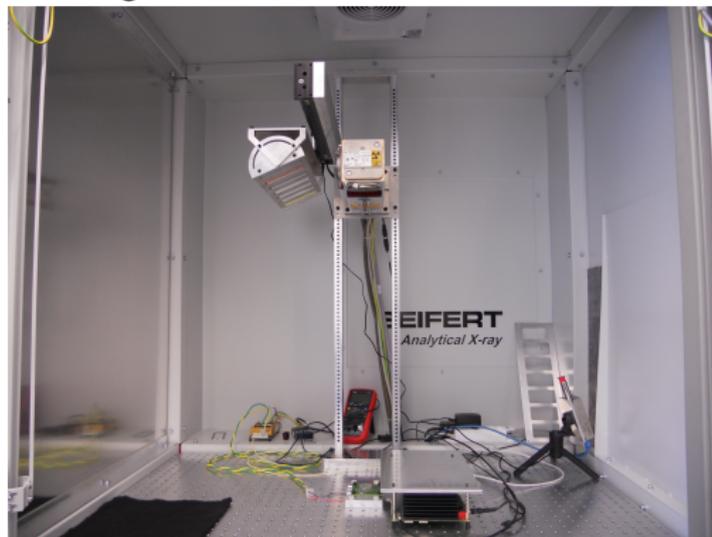
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Setup progress

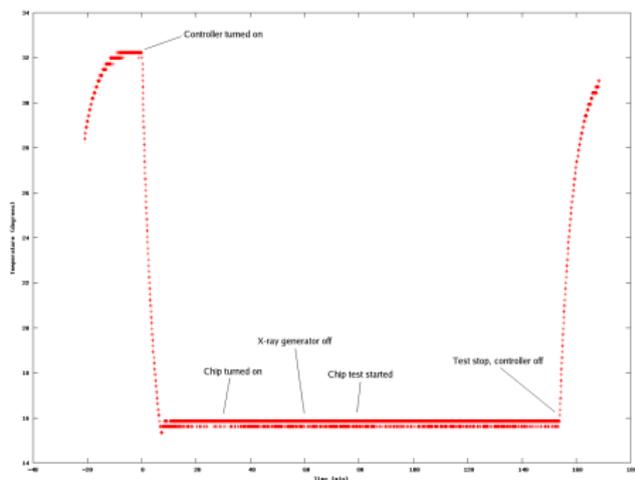
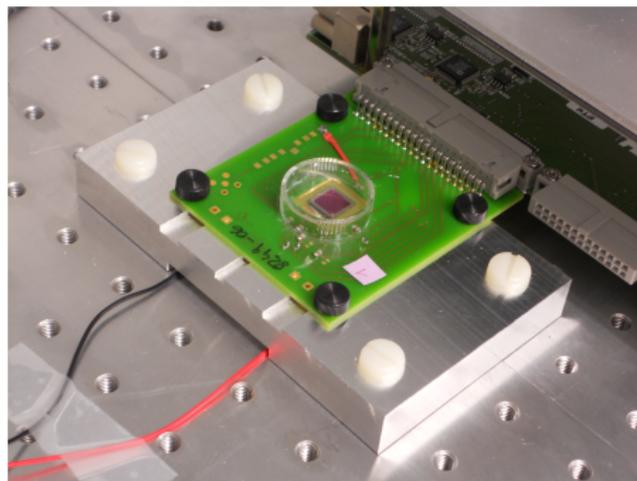
The x-ray setup currently consists of

- ▶ X-ray tube, generator, cabin
- ▶ Single ROC setup with temperature control (17° C) with shielded testboard
- ▶ Movable array of fluorescence targets
- ▶ Spectrometer



Single ROC setup

- ▶ ROC in thermal contact with cooling plate
- ▶ Plate cooled with peltier element, measured with Pt1000
- ▶ Temperature controller establishes stable conditions
- ▶ Not in final state yet



Fluorescence setup

- ▶ Array with 7 slots for target materials
- ▶ Target change through motion of entire array with linear stage
- ▶ Construction designed for minimal parasitic fluorescence emission and for large yield
- ▶ Option for K_{β} filtering (attachment not shown in picture)
- ▶ Targets obtained until now: Iron (Fe), Copper (Cu), Molybdenum (Mo), Silver (Ag), Tin (Sn)
- ▶ Target under evaluation: Barium (Ba) compound (powder)



Fluorescence spectra

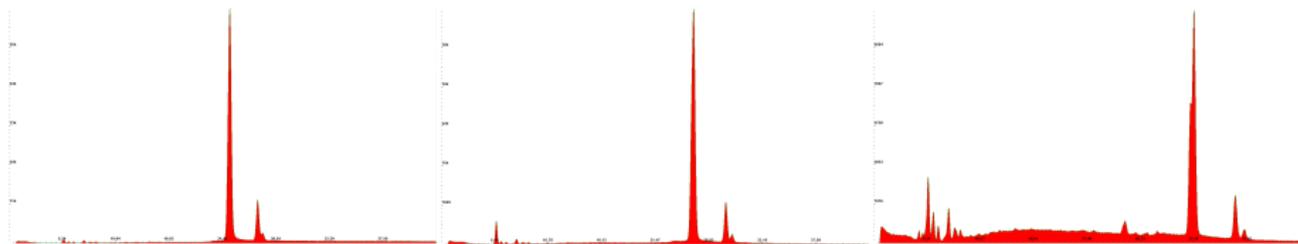
Spectra of all materials using current setup:



Steel (Fe)

Copper (Cu)

Molybdenum (Mo)



Silver (Ag)

Tin (Sn)

Barium chloride

High rate pixel map test

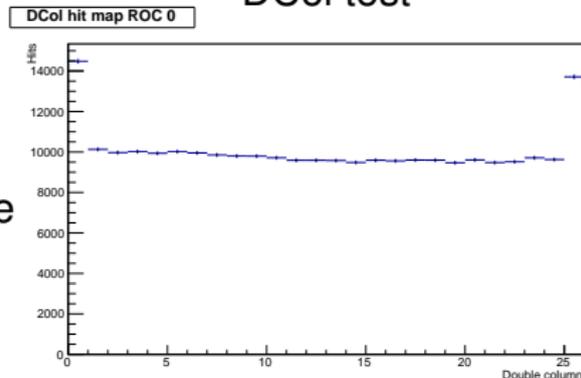
Features:

- ▶ Triggers at a user set frequency
- ▶ Test duration user set
- ▶ Accumulated pixel hits sent to the computer
- ▶ Pixel hits histogrammed in 2d and 1d
- ▶ Pulse height histogrammed
- ▶ Hit multiplicity histogrammed
- ▶ Time < 1 min total

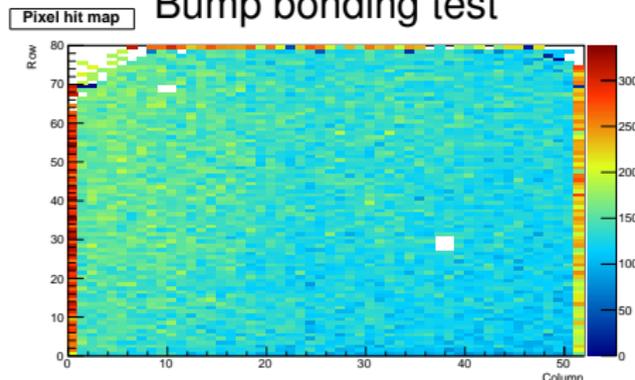
Used for

- ▶ Double column test
- ▶ Bump bonding test

DCol test



Bump bonding test

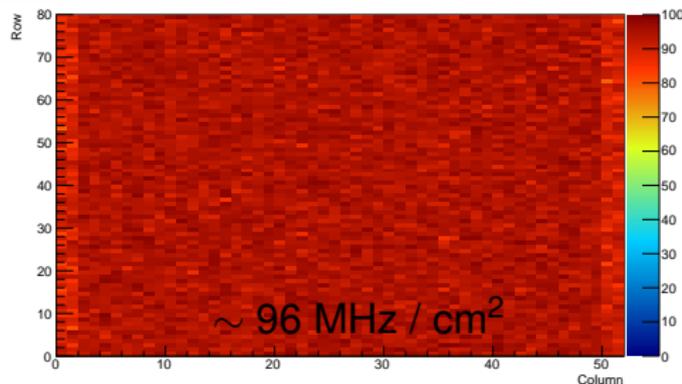


High rate efficiency test

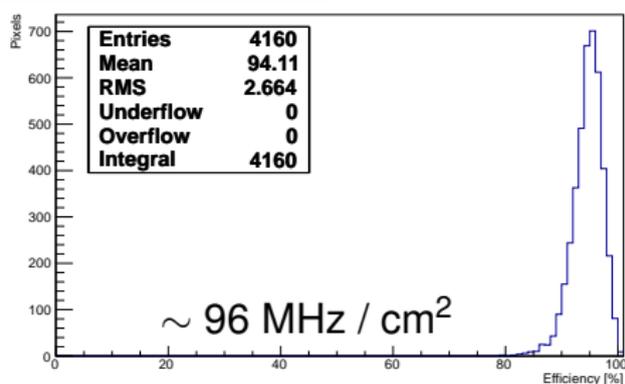
Features

- ▶ Uses calibrate signal to inject each pixel N times along with x-rays
- ▶ Reads out hits, distinguishing pixels
- ▶ Compares number of read out pixels with N to compute efficiency
- ▶ Time ~ 2 min (1 ROC, bandwidth limited)

Pixel efficiency map module



Pixel efficiency distribution ROC 0

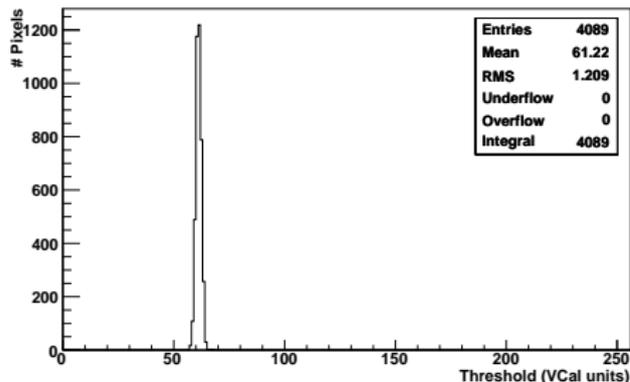


High rate s-curve test

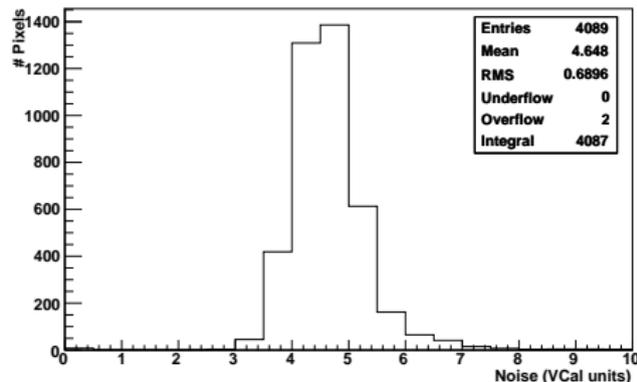
Features

- ▶ Determines the s-curve for each pixel in terms of VCal by injecting the calibrate signal with varying strength
- ▶ Works while under x-ray radiation
- ▶ Time \sim 30 min (1 ROC, bandwidth limited)

Threshold (xray) \sim 93 MHz / cm²



Noise (xray) \sim 93 MHz / cm²



VCal calibration

Using existing test:

- ▶ VcThr scan while under monochromatic x-rays → s-curve
- ▶ Set found value of VcThr
- ▶ Threshold map in terms of VCal for all pixels
- ▶ Averages over all pixels on a chip
- ▶ Yields VCal corresponding to x-ray energy
- ▶ Use multiple x-ray lines to make linear calibration

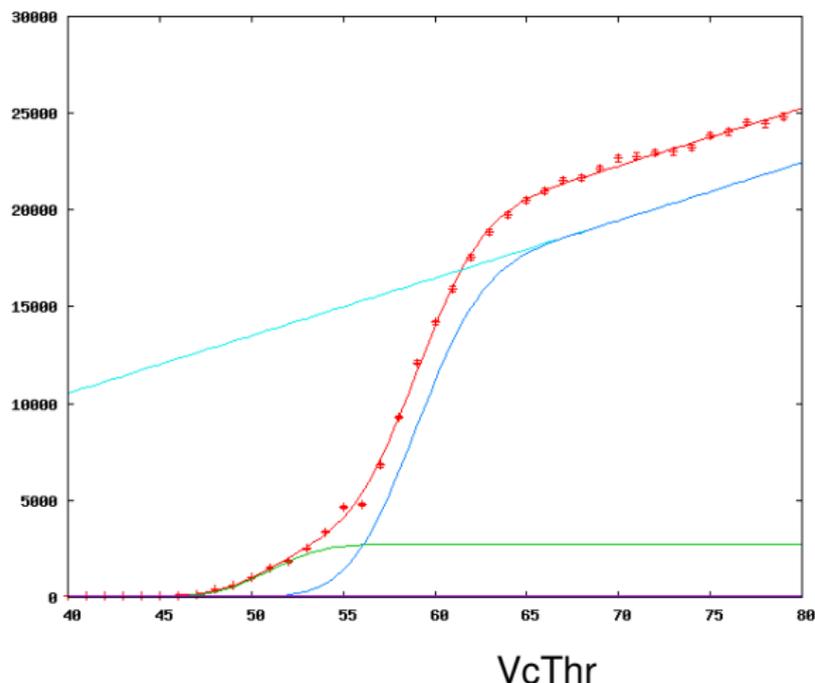
Time:

- ▶ Takes 3 minutes per line (clock stretch 100, 30k Triggers)
- ▶ Yields 20k Hits above threshold (in old module test: < 1k)
- ▶ Can increase trigger frequency by factor of 10 (firmware change)
- ▶ Can live with only 2k Hits or increase time spent
- ▶ Can test multiple modules at once

S-curve for VCal calibration

VcThr scan with monochromatic x-rays (Molybdenum fluorescence)

$a = 51.0142$	± 0.6055	(1.187%)
$b = 2.37153$	± 0.2979	(12.56%)
$c = 2754$	± 567	(20.59%)
$d = 58.7048$	± 0.1589	(0.2707%)
$e = 2.82404$	± 0.2015	(7.135%)
$f = 297.546$	± 25.95	(8.721%)
$g = 17782$	± 767.7	(4.318%)
$h = 56.7872$	± 9.378	(16.51%)



Summary

- ▶ A working setup exists for single ROCs
- ▶ Setup for direct and fluorescence illumination is done
- ▶ Many tests are implemented and working

Outlook:

- ▶ Measure fluorescence and direct spectra (with Daniel Narrias)
- ▶ Measure beam profile for designing module setup (with Daniel)
- ▶ Understand some issues that measurements show

More distant outlook:

- ▶ Verify tests work with full modules
- ▶ Design module setup
- ▶ Implement more tests (?)